

Search Notes



Application/Control No.

10/666,064

Examiner

Linh V. Nguyen

Applicant(s)/Patent under Reexamination

VINCENT ET AL.

Art Unit

2819

SEARCHED

Class	Subclass	Date	Examiner
341	118	5/9/05	L
341	120	5/9/05	L
341	155-170	5/9/05	L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
341	118	5/9/05	L
341	120	5/9/05	L

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
delay lines, first timer delay, second	5/9/05	L
reference, dll, delay lock loop, Analog, digital	5/9/05	L